## FORM HDP-1449 (Based on Form PTO-1449)

PATENT AND TRADEMARK OFFICE
INFORMATION DISCLOSURE CITATION
(Use several sheets if necessary)

Sheet 1 of 1

ATTORNEY DOCKET No.	SERIAL NO.		
24500-000015/US	10/525,499		
APPLICANT			
Valerie BOUSQUET, et al.			
FILING DATE	GROUP		
September 21, 2005	2891		

Sheet 1 of 1

U.S. PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Name	Class/ Subclass	(If appropriate) Filing Date
_						

FOREIGN PATENT DOCUMENTS						
Ref. Desig.	Examiner's Initials	Document Number	Date	Country	Class/ Subclass	Translation Yes No
			-			

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, etc.)		
Examiner's Initials		
	Japanese Office Action dated July 10, 2009.	
	Selkoh Yoshida, "Photoluminescence measurement of InGaN and GaN grown by a gas-source molecular-beam epitaxy method", J. Appl. Phys., Vol. 81, No. 12, pp. 7966-7969 (1997).	
	N. Grandjeen, et al., "Real time control of In <sub>x</sub> Ga <sub>1-x</sub> N molecular beam epitaxy growth", Appl. Phys. Lett., Vol. 72, No. 9, pp. 1078-1080 (1998).	
-	Examiner's	

DJD/ACC:vrj

Examiner:	Date Considered:
<del></del>	